## Power MOSFET

| PRODUCT SUMMARY |  |  |
| :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DS}}(\mathrm{V})$ | -100 |  |
| $\mathrm{R}_{\mathrm{DS}(o n)}(\Omega)$ | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}$ | 1.2 |
| $\mathrm{Q}_{\mathrm{g}}(\mathrm{Max}).(\mathrm{nC})$ | 8.7 |  |
| $\mathrm{Q}_{\mathrm{gs}}(\mathrm{nC})$ | 2.2 |  |
| $\mathrm{Q}_{\mathrm{gd}}(\mathrm{nC})$ |  |  |
| Configuration | 4.1 |  |


P-Channel MOSFET

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating complant
- Repetitive Avalanche Rated
- P-Channel
- $175^{\circ} \mathrm{C}$ Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC


## DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.
The D²PAK (TO-263) is a surface mount power package capable of accommodating die size up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The $\mathrm{D}^{2}$ PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

| ORDERING INFORMATION |  |  |
| :---: | :---: | :---: |
| Package | D2PAK (TO-263) | D2PAK (TO-263) |
| Lead (Pb)-free and Halogen-free | SiHF9510S-GE3 | SiHF9510STRL-GE3 ${ }^{\text {a }}$ |
| Lead (Pb)-free | IRF9510SPbF | IRF9510STRLPbFa |
|  | SiHF9510S-E3 | SiHF9510STL-E3 ${ }^{\text {a }}$ |

## Note

a. See device orientation.

| PARAMETER |  |  | SYMBOL | LIMIT | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Drain-Source Voltage |  |  | $V_{\text {DS }}$ | -100 | V |
| Gate-Source Voltage |  |  | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 20$ |  |
| Continuous Drain Current | $\mathrm{V}_{\mathrm{GS}}$ at - 10 V | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | ID | -4.0 | A |
|  |  | $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  | -2.8 |  |
| Pulsed Drain Current ${ }^{\text {a }}$ |  |  | $\mathrm{I}_{\mathrm{DM}}$ | -16 |  |
| Linear Derating Factor |  |  |  | 0.29 | W/ ${ }^{\circ} \mathrm{C}$ |
| Linear Derating Factor (PCB Mount) ${ }^{\text {e }}$ |  |  |  | 0.025 |  |
| Single Pulse Avalanche Energy ${ }^{\text {b }}$ |  |  | $\mathrm{E}_{\text {AS }}$ | 200 | mJ |
| Avalanche Current ${ }^{\text {a }}$ |  |  | $\mathrm{I}_{\text {AR }}$ | -4.0 | A |
| Repetiitive Avalanche Energy ${ }^{\text {a }}$ |  |  | $\mathrm{E}_{\text {AR }}$ | 4.3 | mJ |
| Maximum Power Dissipation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | $P_{\text {D }}$ | 43 | W |
| Maximum Power Dissipation (PCB Mount) ${ }^{\text {e }}$ | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | 3.7 |  |
| Peak Diode Recovery dV/dt ${ }^{\text {c }}$ |  |  | dV/dt | -5.5 | V/ns |
| Operating Junction and Storage Temperature Range |  |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | - 55 to + 175 | ${ }^{\circ} \mathrm{C}$ |
| Soldering Recommendations (Peak Temperature) | for 10 s |  |  | $300{ }^{\text {d }}$ |  |

## Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. $\mathrm{V}_{\mathrm{DD}}=-25 \mathrm{~V}$, starting $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{L}=18 \mathrm{mH}, \mathrm{R}_{\mathrm{g}}=25 \Omega, \mathrm{I}_{\mathrm{AS}}=-4.0 \mathrm{~A}$ (see fig. 12).
c. $\mathrm{I}_{\mathrm{SD}} \leq-4.0 \mathrm{~A}, \mathrm{dl} / \mathrm{dt} \leq 75 \mathrm{~A} / \mu \mathrm{s}, \mathrm{V}_{\mathrm{DD}} \leq \mathrm{V}_{\mathrm{DS}}, \mathrm{T}_{\mathrm{J}} \leq 175^{\circ} \mathrm{C}$.
d. 1.6 mm from case.
e. When mounted on 1 " square PCB (FR-4 or G-10 material).

* Pb containing terminations are not RoHS compliant, exemptions may apply

| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| Maximum Junction-to-Ambient | $\mathrm{R}_{\mathrm{thJA}}$ | - | 62 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Maximum Junction-to-Ambient (PCB Mount) ${ }^{\text {a }}$ | $\mathrm{R}_{\text {thJA }}$ | - | 40 |  |
| Maximum Junction-to-Case (Drain) | $\mathrm{R}_{\text {thJc }}$ | - | 3.5 |  |

## Note

a. When mounted on $1^{\prime \prime}$ square PCB (FR-4 or G-10 material).

| SPECIFICATIONS $\left(T_{J}=25^{\circ} \mathrm{C}\right.$, unless otherwise noted) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER | SYMBOL | TEST CONDITIONS |  | MIN. | TYP. | MAX. | UNIT |
| Static |  |  |  |  |  |  |  |
| Drain-Source Breakdown Voltage | $\mathrm{V}_{\mathrm{DS}}$ | $\mathrm{V}_{\mathrm{GS}}=0, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ |  | -100 | - | - | V |
| $\mathrm{V}_{\text {DS }}$ Temperature Coefficient | $\Delta \mathrm{V}_{\mathrm{DS}} / \mathrm{T}_{\mathrm{J}}$ | Reference to $25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{D}}=-1 \mathrm{~mA}$ |  | - | -0.091 | - | V/ ${ }^{\circ} \mathrm{C}$ |
| Gate-Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}(\text { (th) }}$ | $V_{D S}=V_{G S}, I_{D}=-250 \mu \mathrm{~A}$ |  | -2.0 | - | -4.0 | V |
| Gate-Source Leakage | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ |  | - | - | $\pm 100$ | nA |
| Zero Gate Voltage Drain Current | IdSs | $\mathrm{V}_{\mathrm{DS}}=-100 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | - | - | -100 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=-80 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=150{ }^{\circ} \mathrm{C}$ |  | - | - | - 500 |  |
| Drain-Source On-State Resistance | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}$ |  | - | - | 1.2 | $\Omega$ |
| Forward Transconductance | $\mathrm{g}_{\text {fs }}$ | $V_{D S}=-50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-2.4 \mathrm{~A}^{\mathrm{b}}$ |  | 1.0 | - | - | S |
| Dynamic |  |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $\begin{gathered} V_{G S}=0 V \\ V_{\mathrm{GS}}=-25 \mathrm{~V}, \\ \mathrm{f}=1.0 \mathrm{MHz}, \text { see fig. } 5 \end{gathered}$ |  | - | 200 | - | pF |
| Output Capacitance | Coss |  |  | - | 94 | - |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  |  | - | 18 | - |  |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}$ | $\begin{gathered} \mathrm{I}_{\mathrm{D}}=-4.0 \mathrm{~A}, \mathrm{~V}_{\mathrm{DS}}=-80 \mathrm{~V}, \\ \text { see fig. } 6 \text { and } 13^{\mathrm{b}} \end{gathered}$ | - | - | 8.7 | nC |
| Gate-Source Charge | $\mathrm{Q}_{\mathrm{gs}}$ |  |  | - | - | 2.2 |  |
| Gate-Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ |  |  | - | - | 4.1 |  |
| Turn-On Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{On})}$ | $\begin{gathered} V_{D D}=-50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-4.0 \mathrm{~A}, \\ R_{g}=24 \Omega, R_{D}=11 \Omega \text {, see fig. } 10^{\mathrm{b}} \end{gathered}$ |  | - | 10 | - | ns |
| Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  |  | - | 27 | - |  |
| Turn-Off Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{fff})}$ |  |  | - | 15 | - |  |
| Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  |  | - | 17 | - |  |
| Internal Drain Inductance | $L_{D}$ | Between lead, $6 \mathrm{~mm}(0.25$ ") from package and center of die contact |  | - | 4.5 | - | nH |
| Internal Source Inductance | $\mathrm{L}_{\mathrm{s}}$ |  |  | - | 7.5 | - |  |
| Drain-Source Body Diode Characteristics |  |  |  |  |  |  |  |
| Continuous Source-Drain Diode Current | Is | MOSFET symbol showing the integral reverse $\mathrm{p}-\mathrm{n}$ junction diode |  | - | - | -4.0 | A |
| Pulsed Diode Forward Current ${ }^{\text {a }}$ | $I_{\text {SM }}$ |  |  | - | - | -16 |  |
| Body Diode Voltage | $\mathrm{V}_{\text {SD }}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{S}}=-4.0 \mathrm{~A}, \mathrm{~V}$ GS $=0 \mathrm{Vb}$ |  | - | - | -5.5 | V |
| Body Diode Reverse Recovery Time | $\mathrm{t}_{\mathrm{rr}}$ | $\mathrm{T}_{J}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=-4.0 \mathrm{~A}, \mathrm{dl} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}^{\mathrm{b}}$ |  | - | 82 | 160 | ns |
| Body Diode Reverse Recovery Charge | $\mathrm{Q}_{\mathrm{rr}}$ |  |  | - | 0.15 | 0.30 | $\mu \mathrm{C}$ |
| Forward Turn-On Time | $\mathrm{t}_{\text {on }}$ | Intrinsic turn-on time is negligible (turn-on is dominated by $L_{S}$ and $L_{D}$ ) |  |  |  |  |  |

## Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width $\leq 300 \mu \mathrm{~s}$; duty cycle $\leq 2 \%$.

TYPICAL CHARACTERISTICS $\left(25^{\circ} \mathrm{C}\right.$, unless otherwise noted)


Fig. 1 - Typical Output Characteristics, $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$


91071_02
$\mathrm{V}_{\mathrm{DS}}$, Drain-to-Source Voltage (V)

Fig. 3 - Typical Transfer Characteristics


Fig. 4 - Normalized On-Resistance vs. Temperature


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage


Fig. 7 - Typical Source-Drain Diode Forward Voltage


Fig. 8 - Maximum Safe Operating Area


Fig. 9 - Maximum Drain Current vs. Case Temperature


Fig. 10a - Switching Time Test Circuit


Fig. 10b - Switching Time Waveforms


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case


Fig. 12a - Unclamped Inductive Test Circuit


Fig. 12b - Unclamped Inductive Waveforms


Fig. 12c - Maximum Avalanche Energy vs. Drain Current


Fig. 13a - Basic Gate Charge Waveform


Fig. 13b - Gate Charge Test Circuit

a. $\mathrm{V}_{\mathrm{GS}}=-5 \mathrm{~V}$ for logic level and -3 V drive devices

Fig. 14 - For P-Channel

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Package Information
Vishay Siliconix

## TO-263AB (HIGH VOLTAGE)



## Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Dimensions are shown in millimeters (inches).
3. Dimension D and E do not include mold flash. Mold flash shall not exceed $0.127 \mathrm{~mm}\left(0.005{ }^{\prime \prime}\right)$ per side. These dimensions are measured at the outmost extremes of the plastic body at datum $A$.
4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
5. Dimension b1 and c1 apply to base metal only.
6. Datum $A$ and $B$ to be determined at datum plane $H$.
7. Outline conforms to JEDEC outline to TO-263AB.

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